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# FDMS86104

## N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET

100 V, 16 A, 24 mΩ

### Features

- Shielded Gate MOSFET Technology
- Max  $r_{DS(on)}$  = 24 mΩ at  $V_{GS} = 10\text{ V}$ ,  $I_D = 7\text{ A}$
- Max  $r_{DS(on)}$  = 39 mΩ at  $V_{GS} = 6\text{ V}$ ,  $I_D = 5.5\text{ A}$
- Advanced Package and Silicon combination for low  $r_{DS(on)}$  and high efficiency
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

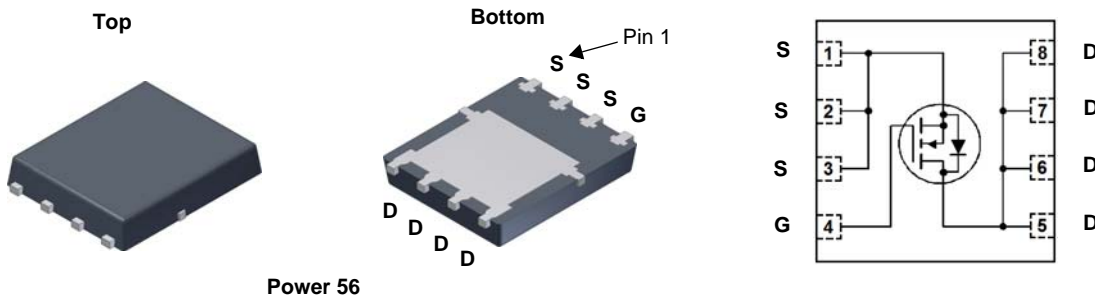


### General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

### Application

- DC-DC Conversion



### MOSFET Maximum Ratings $T_A = 25\text{ °C}$ unless otherwise noted

| Symbol         | Parameter                                        | Rated                          | Units |
|----------------|--------------------------------------------------|--------------------------------|-------|
| $V_{DS}$       | Drain to Source Voltage                          | 100                            | V     |
| $V_{GS}$       | Gate to Source Voltage                           | ±20                            | V     |
| $I_D$          | Drain Current -Continuous                        | $T_C = 25\text{ °C}$           | 16    |
|                | -Continuous                                      | $T_A = 25\text{ °C}$ (Note 1a) | 7     |
|                | -Pulsed                                          |                                | 30    |
| $E_{AS}$       | Single Pulse Avalanche Energy                    | (Note 3)                       | 96    |
| $P_D$          | Power Dissipation                                | $T_C = 25\text{ °C}$           | 73    |
|                | Power Dissipation                                | $T_A = 25\text{ °C}$ (Note 1a) | 2.5   |
| $T_J, T_{STG}$ | Operating and Storage Junction Temperature Range | -55 to +150                    | °C    |

### Thermal Characteristics

|                 |                                                   |     |      |
|-----------------|---------------------------------------------------|-----|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case              | 1.7 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 50  |      |

### Package Marking and Ordering Information

| Device Marking | Device    | Package  | Reel Size | Tape Width | Quantity   |
|----------------|-----------|----------|-----------|------------|------------|
| FDMS86104      | FDMS86104 | Power 56 | 13"       | 12 mm      | 3000 units |

FDMS86104 N-Channel Shielded Gate PowerTrench<sup>®</sup> MOSFET

## Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

### Off Characteristics

|                                      |                                           |                                                                           |     |    |           |                      |
|--------------------------------------|-------------------------------------------|---------------------------------------------------------------------------|-----|----|-----------|----------------------|
| $BV_{DSS}$                           | Drain to Source Breakdown Voltage         | $I_D = 250\text{ }\mu\text{A}, V_{GS} = 0\text{ V}$                       | 100 |    |           | V                    |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$ |     | 66 |           | mV/ $^\circ\text{C}$ |
| $I_{DSS}$                            | Zero Gate Voltage Drain Current           | $V_{DS} = 80\text{ V}, V_{GS} = 0\text{ V}$                               |     |    | 1         | $\mu\text{A}$        |
| $I_{GSS}$                            | Gate to Source Leakage Current            | $V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$                           |     |    | $\pm 100$ | nA                   |

### On Characteristics

|                                        |                                                          |                                                                           |   |     |    |                      |
|----------------------------------------|----------------------------------------------------------|---------------------------------------------------------------------------|---|-----|----|----------------------|
| $V_{GS(th)}$                           | Gate to Source Threshold Voltage                         | $V_{GS} = V_{DS}, I_D = 250\text{ }\mu\text{A}$                           | 2 | 2.9 | 4  | V                    |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | $I_D = 250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$ |   | -10 |    | mV/ $^\circ\text{C}$ |
| $r_{DS(on)}$                           | Static Drain to Source On Resistance                     | $V_{GS} = 10\text{ V}, I_D = 7\text{ A}$                                  |   | 20  | 24 | m $\Omega$           |
|                                        |                                                          | $V_{GS} = 6\text{ V}, I_D = 5.5\text{ A}$                                 |   | 27  | 39 |                      |
|                                        |                                                          | $V_{GS} = 10\text{ V}, I_D = 7\text{ A}, T_J = 125\text{ }^\circ\text{C}$ |   | 33  | 40 |                      |
| $g_{FS}$                               | Forward Transconductance                                 | $V_{DS} = 10\text{ V}, I_D = 7\text{ A}$                                  |   | 18  |    | S                    |

### Dynamic Characteristics

|           |                              |                                                                    |  |     |     |    |
|-----------|------------------------------|--------------------------------------------------------------------|--|-----|-----|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 50\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1\text{ MHz}$ |  | 694 | 923 | pF |
| $C_{oss}$ | Output Capacitance           |                                                                    |  | 178 | 237 |    |
| $C_{rss}$ | Reverse Transfer Capacitance |                                                                    |  | 8   | 13  |    |
| $R_g$     | Gate Resistance              |                                                                    |  | 0.5 |     |    |

### Switching Characteristics

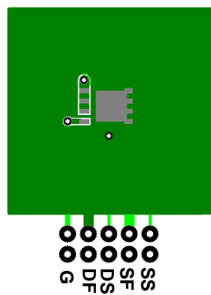
|              |                               |                                                                                                |                                               |      |      |    |
|--------------|-------------------------------|------------------------------------------------------------------------------------------------|-----------------------------------------------|------|------|----|
| $t_{d(on)}$  | Turn-On Delay Time            | $V_{DD} = 50\text{ V}, I_D = 7\text{ A},$<br>$V_{GS} = 10\text{ V}, R_{GEN} = 6\text{ }\Omega$ |                                               | 8    | 16   | ns |
| $t_r$        | Rise Time                     |                                                                                                |                                               | 3.5  | 10   |    |
| $t_{d(off)}$ | Turn-Off Delay Time           |                                                                                                |                                               | 14.3 | 26   |    |
| $t_f$        | Fall Time                     |                                                                                                |                                               | 3.2  | 10   |    |
| $Q_g$        | Total Gate Charge             |                                                                                                | $V_{GS} = 0\text{ V to } 10\text{ V}$         |      | 11.7 |    |
| $Q_g$        | Total Gate Charge             | $V_{GS} = 0\text{ V to } 5\text{ V}$                                                           | $V_{DD} = 50\text{ V},$<br>$I_D = 7\text{ A}$ | 6.7  | 9    |    |
| $Q_{gs}$     | Gate to Source Charge         |                                                                                                |                                               | 3.2  |      | nC |
| $Q_{gd}$     | Gate to Drain "Miller" Charge |                                                                                                |                                               | 3    |      | nC |

### Drain-Source Diode Characteristics

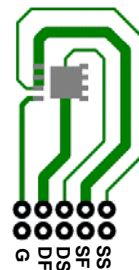
|          |                                       |                                                      |  |     |     |    |
|----------|---------------------------------------|------------------------------------------------------|--|-----|-----|----|
| $V_{SD}$ | Source to Drain Diode Forward Voltage | $V_{GS} = 0\text{ V}, I_S = 2\text{ A}$ (Note 2)     |  | 0.7 | 1.2 | V  |
|          |                                       | $V_{GS} = 0\text{ V}, I_S = 7\text{ A}$ (Note 2)     |  | 0.8 | 1.3 |    |
| $t_{rr}$ | Reverse Recovery Time                 | $I_F = 7\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$ |  | 44  | 70  | ns |
| $Q_{rr}$ | Reverse Recovery Charge               |                                                      |  | 41  | 65  |    |

#### Notes:

- $R_{\theta JA}$  is determined with the device mounted on a  $1\text{ in}^2$  pad 2 oz copper pad on a  $1.5 \times 1.5\text{ in.}$  board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $50\text{ }^\circ\text{C}/\text{W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper.



b.  $125\text{ }^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width <  $300\text{ }\mu\text{s}$ , Duty cycle < 2.0%.

- Starting  $T_J = 25\text{ }^\circ\text{C}$ ,  $L = 3\text{ mH}$ ,  $I_{AS} = 8\text{ A}$ ,  $V_{DD} = 100\text{ V}$ ,  $V_{GS} = 10\text{ V}$

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

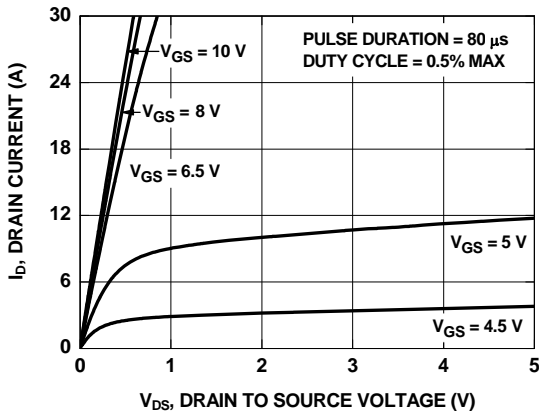


Figure 1. On-Region Characteristics

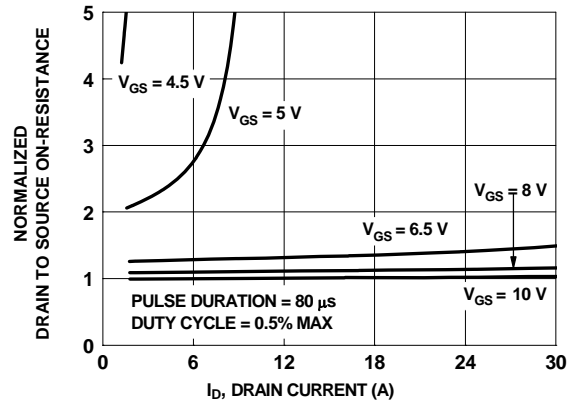


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

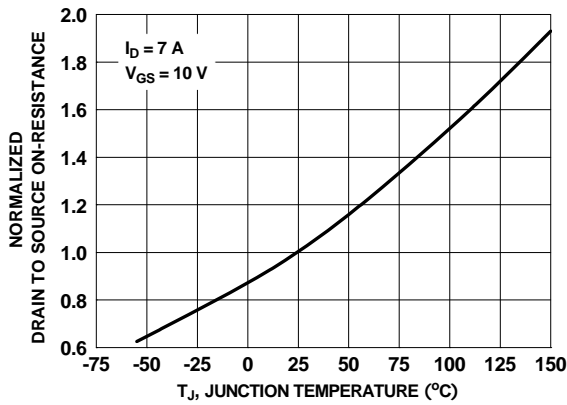


Figure 3. Normalized On-Resistance vs Junction Temperature

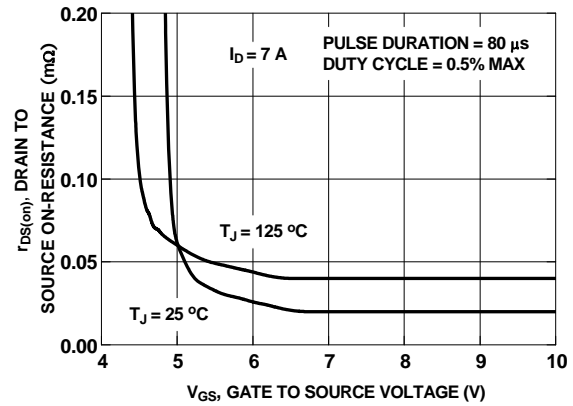


Figure 4. On-Resistance vs Gate to Source Voltage

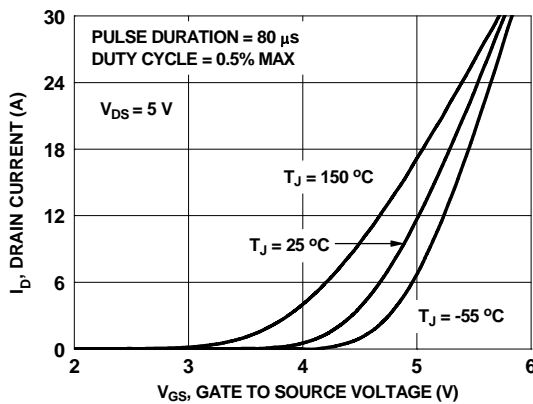


Figure 5. Transfer Characteristics

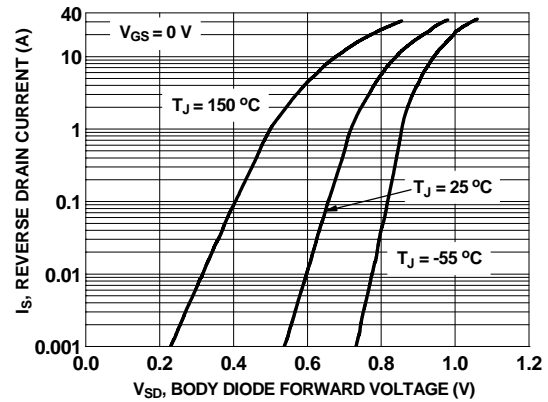
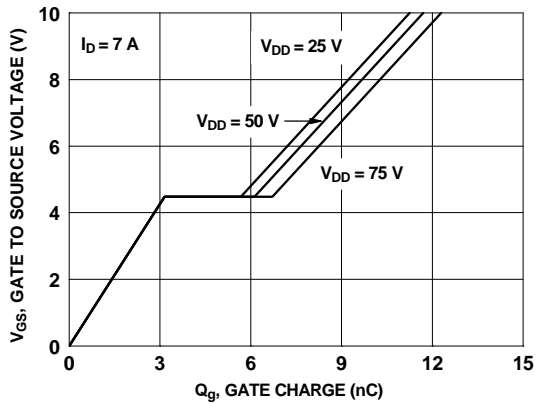
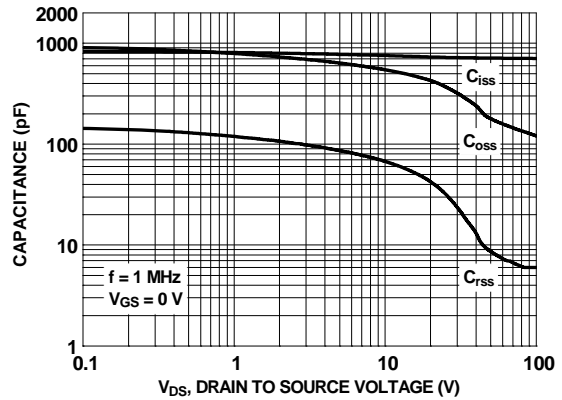


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

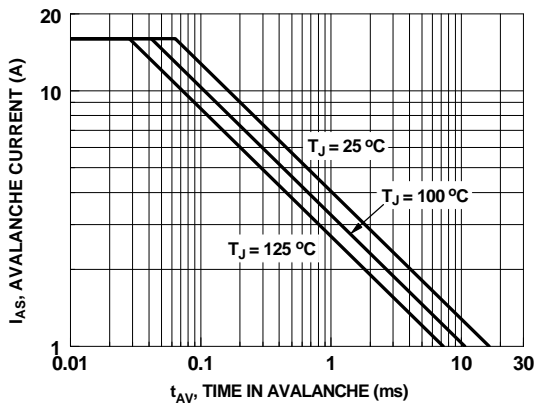
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



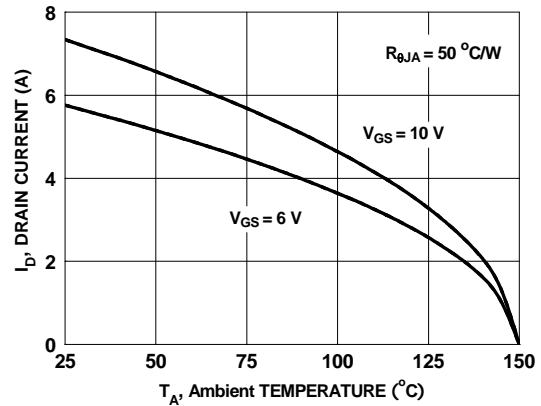
**Figure 7. Gate Charge Characteristics**



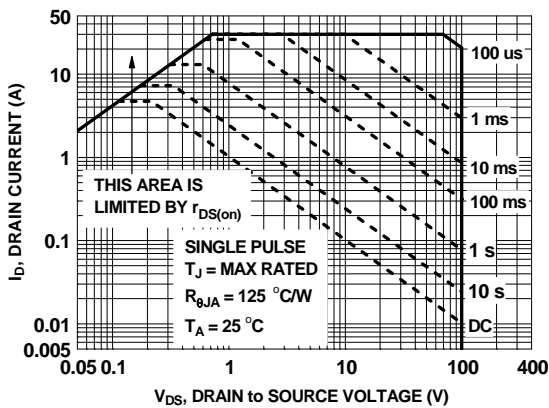
**Figure 8. Capacitance vs Drain to Source Voltage**



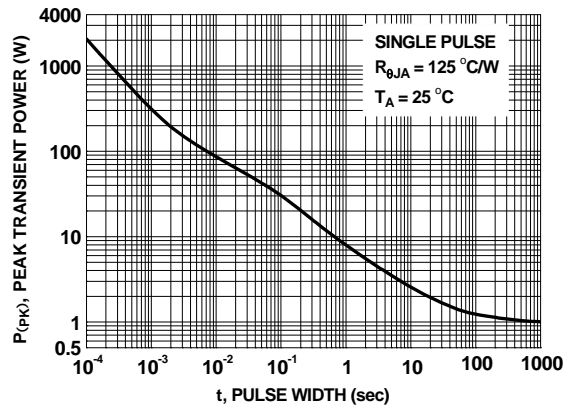
**Figure 9. Unclamped Inductive Switching Capability**



**Figure 10. Maximum Continuous Drain Current vs Ambient Temperature**

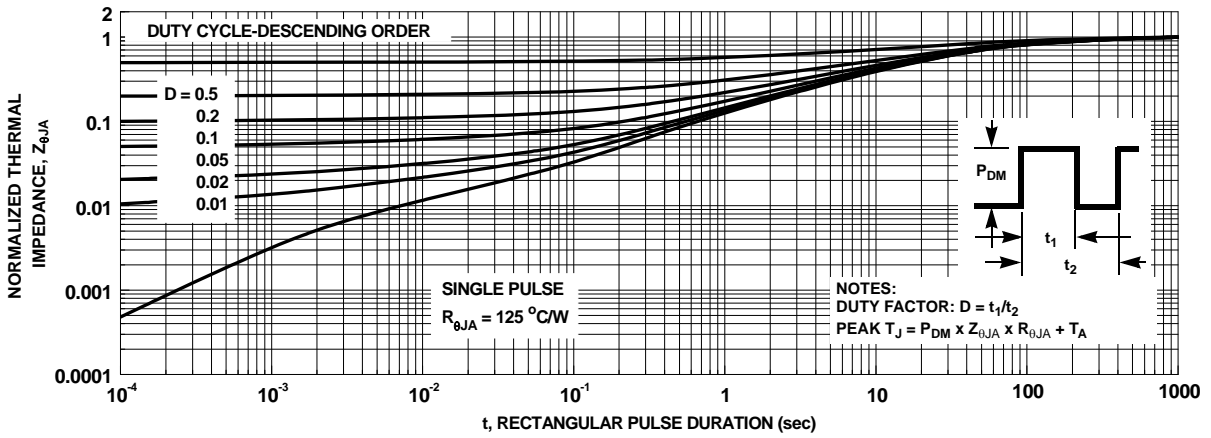


**Figure 11. Forward Bias Safe Operating Area**

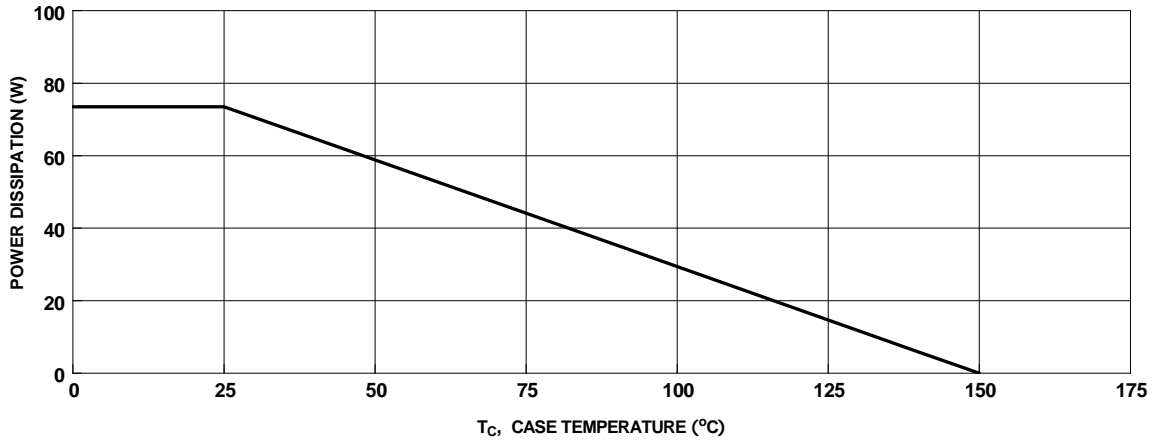


**Figure 12. Single Pulse Maximum Power Dissipation**

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



**Figure 13. Junction-to-Ambient Transient Thermal Response Curve**



**Figure 14. Power Vs Case Temperature**



TOP VIEW



LAND PATTERN RECOMMENDATION



SIDE VIEW

OPTIONAL DRAFT ANGLE MAY APPEAR ON FOUR SIDES OF THE PACKAGE



DETAIL C  
SCALE: 2:1



DETAIL B  
SCALE: 2:1



BOTTOM VIEW

NOTES: UNLESS OTHERWISE SPECIFIED

- A. PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA, DATED OCTOBER 2002.
- B. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- E. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
- F. DRAWING FILE NAME: PQFN08AREV10



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